

### 20V P-CHANNEL ENHANCEMENT MODE MOSFET

## **Product Summary**

BV <sub>DSS</sub>	R <sub>DS(ON)</sub> Max	I <sub>D</sub> T <sub>A</sub> = +25°C
201/	$88m\Omega @ V_{GS} = -8V$	-2.9A
-20V	105mΩ @ $V_{GS} = -4.5V$	-1.8A

## **Description**

This new generation MOSFET is designed to minimize the footprint in handheld and Mobile application. It can be used to replace many small signals MOSFET with as really small footprint.

## **Applications**

- Battery Management
- Load Switch
- Battery Protection
- Handheld and Mobile Application

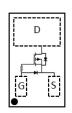
## **Features and Benefits**

- Low Q<sub>g</sub> & Q<sub>gd</sub>
- Small Footprint
- Low Profile 0.30mm Height
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

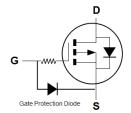
### **Mechanical Data**

- Case: X2-DSN1006-3
- Terminal Connections: See Diagram Below
- Terminals: Finish Matte Tin Annealed over Copper Pillar <a>®</a>

#### X2-DSN1006-3







Equivalent Circuit

July 2018

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## Ordering Information (Note 4)

Part Number	Case	Packaging
DMP2088LCP3-7	X2-DSN1006-3	3000/Tape & Reel

Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.

- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

# **Marking Information**



 $B = Product Type Marking Code \\ YM = Date Code Marking \\ Y or \overline{Y} = Year (ex: F = 2018) \\ M or \overline{M} = Month (ex: 9 = September)$ 

#### Date Code Key

Code

Document number: DS38475 Rev. 4 - 2

•												
Year	2014	2015	2016	2017	2018	2019	2020	2021	2022	2023	2024	2025
Code	В	С	D	Е	F	G	Н		J	K	L	М
												•
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec

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# **Maximum Ratings** $(@T_A = +25^{\circ}C, \text{ unless otherwise specified.})$

Characteristic	Symbol	Value	Unit		
Drain-Source Voltage	V <sub>DSS</sub>	-20	V		
Gate-Source Voltage	$V_{GSS}$	-12	V		
Continuous Drain Current (Note 5) V <sub>GS</sub> = -8V	Steady State	$T_A = +25$ °C $T_A = +70$ °C	I <sub>D</sub>	-2.9 -2.4	А
Continuous Drain Current (Note 5) V <sub>GS</sub> = -4.5V	I <sub>D</sub>	-1.8 -1.4	А		
Pulsed Drain Current (Note 6)	I <sub>DM</sub>	-15	A		
Human Body Model (HBM)	V <sub>(ESD)</sub>	4	kV		

## **Thermal Characteristics**

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 7)	P <sub>D</sub>	0.57	W
Thermal Resistance, Junction to Ambient @T <sub>A</sub> = +25°C (Note 7)	$R_{ heta JA}$	217	°C/W
Power Dissipation (Note 5)	P <sub>D</sub>	1.13	W
Thermal Resistance, Junction to Ambient @T <sub>A</sub> = +25°C (Note 5)	R <sub>0JA</sub>	110	°C/W
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C

## **Electrical Characteristics** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition		
OFF CHARACTERISTICS (Note 8)								
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-20	_	_	V	$V_{GS} = 0V, I_{D} = -250\mu A$		
Zero Gate Voltage Drain Current T <sub>J</sub> = +25°C	I <sub>DSS</sub>	_	_	-100	nA	V <sub>DS</sub> = -16V, V <sub>GS</sub> = 0V		
Gate-Source Leakage	I <sub>GSS</sub>	_	_	-50	nA	$V_{GS} = -12V, V_{DS} = 0V$		
ON CHARACTERISTICS (Note 8)								
Gate Threshold Voltage	V <sub>GS(TH)</sub>	-0.7	-1.0	-1.2	V	$V_{DS} = V_{GS}$ , $I_D = -250\mu A$		
		_	73	88		$V_{GS} = -8V, I_D = -0.5A$		
Static Drain-Source On-Resistance	D	_	90	105	mΩ	$V_{GS} = -4.5V, I_D = -0.5A$		
Static Dialit-Source Off-Resistance	R <sub>DS(ON)</sub>	_	143	174	11152	$V_{GS} = -2.5V, I_D = -0.5A$		
		_	266	750		$V_{GS} = -1.8V, I_D = -0.1A$		
Forward Transfer Admittance	Y <sub>fs</sub>	_	3.4	_	S	$V_{DS} = -10V, I_{D} = -0.5A$		
Diode Forward Voltage	V <sub>SD</sub>	_	-0.75	-1.0	V	V <sub>GS</sub> = 0V, I <sub>S</sub> = -0.5A		
Reverse Recovery Charge	Q <sub>RR</sub>	_	1.0	_	nC	V <sub>DD</sub> = -10V, I <sub>F</sub> = -1A,		
Reverse Recovery Time	t <sub>RR</sub>	-	5.7	_	ns	di/dt = 100A/µs		
DYNAMIC CHARACTERISTICS (Note 9)	•			•				
Input Capacitance	C <sub>iss</sub>	l	121	160		10)/ )/ 0)/		
Output Capacitance	Coss	_	66	100	pF	$V_{DS} = -10V, V_{GS} = 0V,$ f = 1.0MHz		
Reverse Transfer Capacitance	C <sub>rss</sub>	_	4.3	8		I = 1.0IVII IZ		
Series Gate Resistance	$R_{G}$	9	18	36	Ω	$f = 1MHz$ , $V_{GS} = 0V$ , $V_{DS} = 0V$		
Total Gate Charge	Qg	_	1.1	1.5				
Gate-Source Charge	$Q_{gs}$	_	0.17	_	nC	$V_{GS} = -4.5V, V_{DS} = -10V,$		
Gate-Drain Charge	$Q_{gd}$	_	0.22	_	i iiC	$I_D = -0.5A$		
Gate Charge at V <sub>TH</sub>	Q <sub>g(th)</sub>	_	0.12	_				
Turn-On Delay Time	t <sub>D(ON)</sub>	_	6.3	12				
Turn-On Rise Time	t <sub>R</sub>	-	2.8	_		$V_{DS} = -10V, V_{GS} = -4.5V,$		
Turn-Off Delay Time	t <sub>D(OFF)</sub>	_	17	34	ns	$R_G = 2\Omega$ , $I_D = -0.5A$		
Turn-Off Fall Time	t <sub>F</sub>	_	6	_				

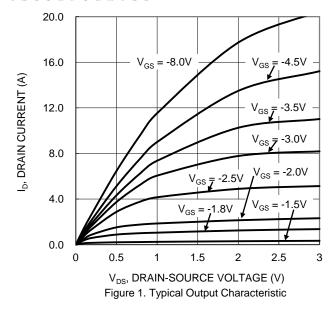
Notes:

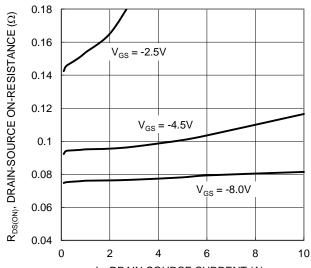
- 5. Device mounted on FR-4 material with 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu. 6. Repetitive rating, pulse width limited by junction temperature.
  7. Device mounted on FR-4 PCB with minimum recommended pad layout, single sided.
  8. Short duration pulse test used to minimize self-heating effect.

- 9. Guaranteed by design. Not subject to production testing.









I<sub>D</sub>, DRAIN-SOURCE CURRENT (A) Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

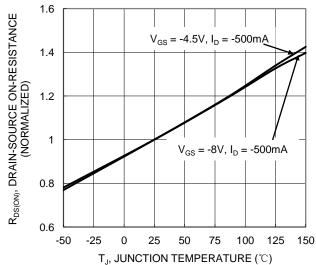


Figure 5. On-Resistance Variation with Junction Temperature

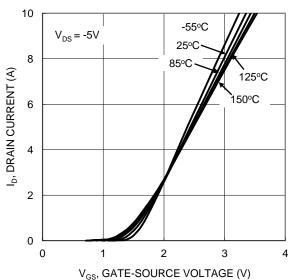


Figure 2. Typical Transfer Characteristic

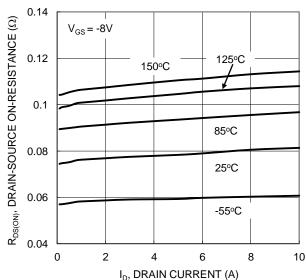


Figure 4. Typical On-Resistance vs. Drain Current and Junction Temperature

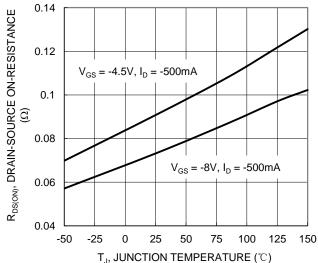
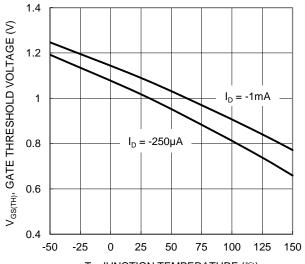


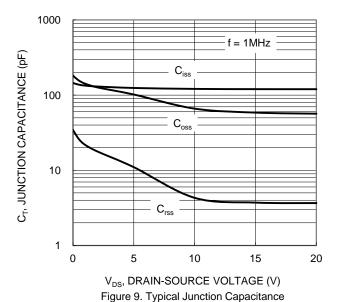
Figure 6. On-Resistance Variation with Junction Temperature





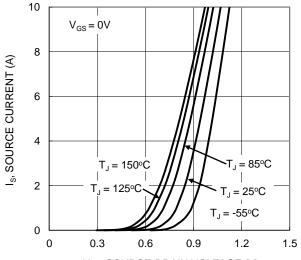


 $T_J$ , JUNCTION TEMPERATURE (°C) Figure 7. Gate Thershold Variation vs. Junction Temperature

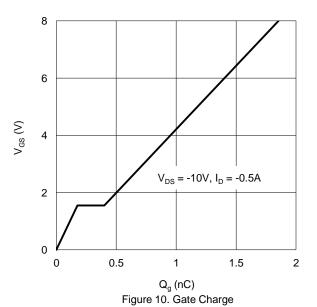


100  $R_{\text{DS}(\text{ON})}$  Limited =100µs =100ms 10 ID, DRAIN CURRENT (A) T<sub>J(Max)</sub>=150°C T<sub>C</sub> = 25°C 0.1  $V_{GS} = -8V$ Single Pulse DUT on 1\*MRP DC Board 0.01 0.1 10 100  $V_{DS}$ , DRAIN-SOURCE VOLTAGE (V)

Figure 11. SOA, Safe Operation Area



V<sub>SD</sub>, SOURCE-DRAIN VOLTAGE (V) Figure 8. Diode Forward Voltage vs. Current





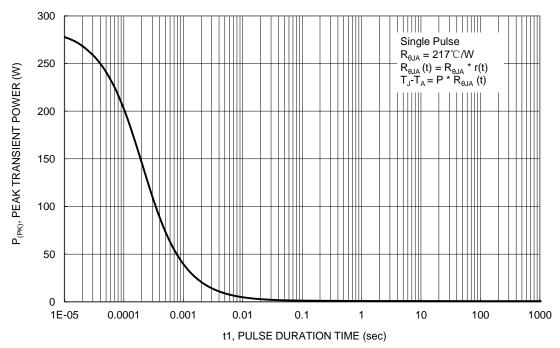


Figure 12. Single Pulse Maximum Power Dissipation

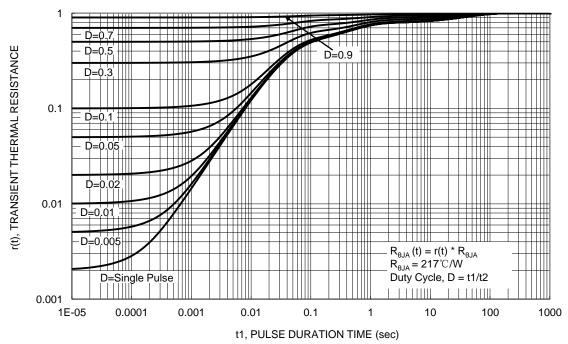


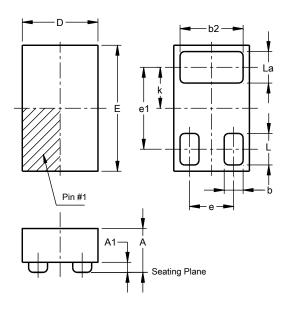
Figure 13. Transient Thermal Resistance



## **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

### X2-DSN1006-3

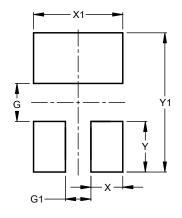


X2-DSN1006-3							
Dim	Min	Max	Тур				
Α		0.348	0.32				
A1			0.08				
b	0.14	0.16	0.15				
b2	0.49	0.51	0.50				
D	0.56	0.64	0.60				
E	0.96	1.04	1.00				
е			0.35				
e1			0.65				
k			0.325				
L	0.21	0.29	0.25				
La	0.21	0.29	0.25				
All Dimensions in mm							

## **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

### X2-DSN1006-3



Dimensions	Value (in mm)
G	0.30
G1	0.20
Х	0.25
X1	0.70
Υ	0.40
Y1	1.10

July 2018

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